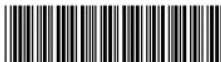


<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10574129	LI ET AL.
Examiner	Art Unit	
AMY H BOWMAN	1635	

### SEARCHED

Class	Subclass	Date	Examiner

### SEARCH NOTES

Search Notes	Date	Examiner
Sequence searches (score over length SEQ ID NO: 1; Search SEQ ID NO: 7)	3/7/08	AHB
WEST	3/12/08	AHB
Inventor Name Search	3/12/08	AHB
MedLine	3/12/08	AHB
Ambion siRNA target finder tool, available at <a href="http://www.ambion.com/techlib/misc/siRNA_finder.html">http://www.ambion.com/techlib/misc/siRNA_finder.html</a>	3/16/08	AHB

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner